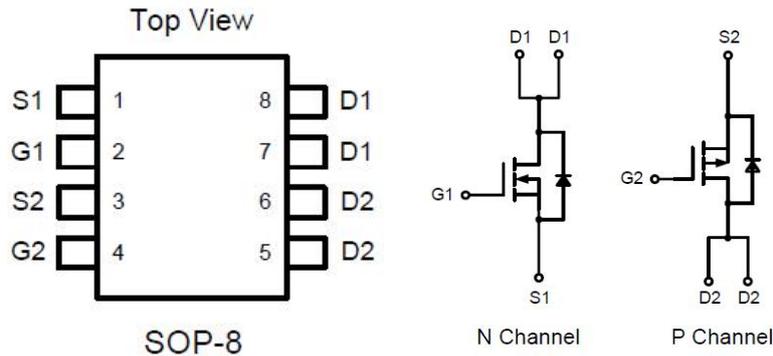




GENERAL DESCRIPTION

The RZC4606D uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge. The complementary MOSFETs may be used to form a level shifted high side switch, and for a host of other applications.

PIN CONFIGURATION



FEATURES

- N-Channel
30V/6A,
 $R_{DS(ON)}=18m\Omega$ (MAX.) @ $V_{GS}=10V$
 $R_{DS(ON)}=28m\Omega$ (MAX.) @ $V_{GS}=4.5V$
- P-Channel
-30V/-6A,
 $R_{DS(ON)}=32m\Omega$ (MAX.) @ $V_{GS}=-10V$
 $R_{DS(ON)}=56m\Omega$ (MAX.) @ $V_{GS}=-4.5V$
- Super High Dense Cell Design
- Reliable and Rugged

APPLICATIONS

- Power Management in Notebook Computer
- Portable Equipment
- Battery Powered Systems

ORDERING INFORMATION

Part Number	Package	Top Marking	Packing
RZC4606D	SOP-8	4606D	3000PCS/Real

**MAXIMUM RATINGS**($T_a = 25^\circ\text{C}$)

Parameter	Symbol	Value		Units	
		N	P		
Drain to Source Voltage	V_{DSS}	30	-30	V	
Gate to Source Voltage	V_{GSS}	± 20	± 20	V	
Continuous Drain Current	I_D	25 $^\circ\text{C}$	6	-6	A
		85 $^\circ\text{C}$	4.8	-4.8	A
Pulsed Drain Current	$I_{D(pulse)}$	24	-24	A	
Maximum Power Dissipation	$P_D(25^\circ\text{C})$	1.5		W	
Operating Junction Temperature	T_J	+150		$^\circ\text{C}$	
Storage Temperature	T_{STG}	-55-+150		$^\circ\text{C}$	
Lead Temperature for Soldering Purposes(1/8" from case for 10 s)	T_L	260		$^\circ\text{C}$	

**ELECTRICAL CHARACTERISTICS**($T_A = 25^\circ\text{C}$)

N-Channel

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX	Units
Drain-Source Breakdown Voltage	BVDSS	$V_{GS}=0V, I_{DS}=250\mu A$	30			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=30V, V_{GS}=0V$			1	μA
Gate Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$			± 100	nA
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$			2.5	V
Drain to Source On-state Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=3.0A$		15	18	$m\Omega$
		$V_{GS}=4.5V, I_D=3.0A$		25	28	$m\Omega$
Drain-Source Diode Forward Voltage	V_{SD}	$I_S=1A, V_{GS}=0V$		0.8	1.3	V
Input Capacitance	C_{iss}	$V_{DS}=30V, V_{GS}=0V, f=1MHz$		570		pF
Output Capacitance	C_{oss}			80		pF
Reverse Transfer Capacitance	C_{rss}			65		pF
Total Gate Charge (10V)	Q_g	$V_{DS}=30V, V_{GS}=10V, I_D=3A$		5.0		nC
Gate-Source Charge	Q_{gs}			1.1		nC
Gate-Drain Charge	Q_{gd}			2.6		nC



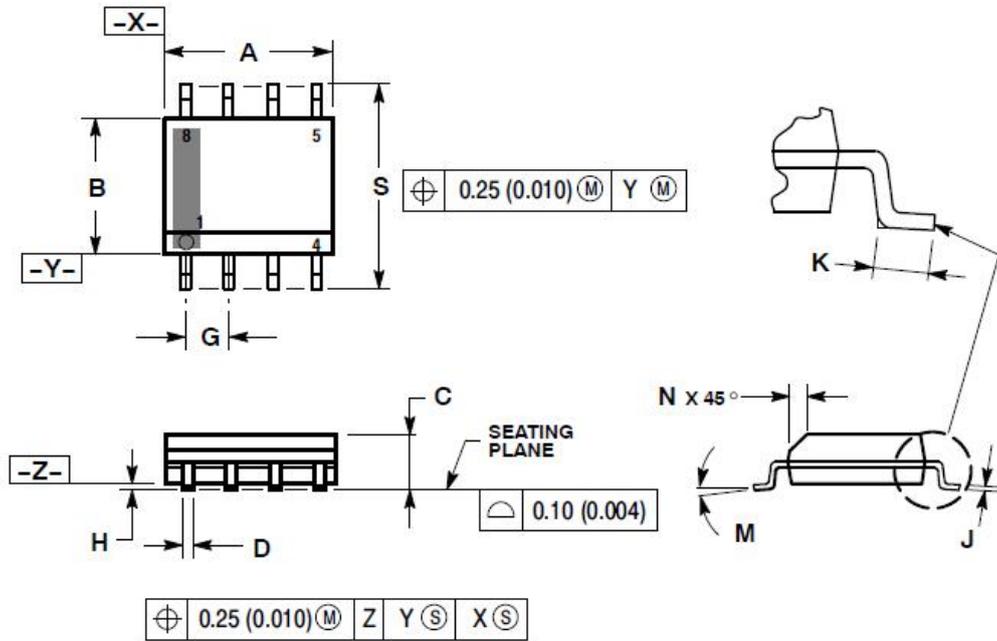
P-Channel

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX	Units
Drain-Source Breakdown Voltage	BVDSS	$V_{GS}=0V, I_{DS}=-250\mu A$	-30			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=-30V, V_{GS}=0V$			-1	μA
Gate Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$			± 100	nA
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-1.5	-2.0	-2.5	V
Drain to Source On-state Resistance	$R_{DS(on)}$	$V_{GS}=-10V, I_D=-3.0A$		28	32	$m\Omega$
		$V_{GS}=-4.5V, I_D=-3.0A$		50	56	$m\Omega$
Drain-Source Diode Forward Voltage	V_{SD}	$I_S=-1A, V_{GS}=0V$	-2.5	-2.0	-1.5	V
Input Capacitance	C_{iss}	$V_{DS}=-30V, V_{GS}=0V, f=1MHz$		922		pF
Output Capacitance	C_{oss}			150		pF
Reverse Transfer Capacitance	C_{rss}			122		pF
Total Gate Charge (10V)	Q_g	$V_{DS}=-30V, V_{GS}=-10V, I_D=-3A$		9.6		nC
Gate-Source Charge	Q_{gs}			2.2		nC
Gate-Drain Charge	Q_{gd}			3.3		nC

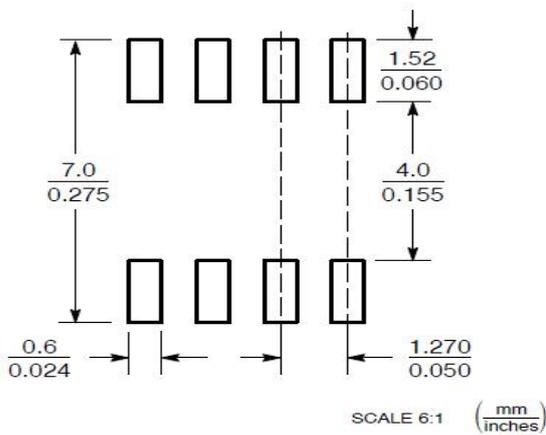


PACKAGE DIMENSIONS

SOP-8



SOLDERING FOOTPRINT*



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.80	5.00	0.189	0.197
B	3.80	4.00	0.150	0.157
C	1.35	1.75	0.053	0.069
D	0.33	0.51	0.013	0.020
G	1.27 BSC		0.050 BSC	
H	0.10	0.25	0.004	0.010
J	0.19	0.25	0.007	0.010
K	0.40	1.27	0.016	0.050
M	0 °	8 °	0 °	8 °
N	0.25	0.50	0.010	0.020
S	5.80	6.20	0.228	0.244